

# CBT16292

## 12-bit 1-of-2 multiplexer/demultiplexer

Rev. 02 — 18 April 2008

Product data sheet

### 1. General description

The CBT16292 is a 12-bit 1-of-2 high-speed TTL-compatible multiplexer/demultiplexer. The low ON resistance of the switch allows connections to be made with minimal propagation delay.

When the select input (S) is LOW, port nA is connected to port nB1 and port nB2 is connected to GND via an internal pull-down resistor (500  $\Omega$ ). When select input (S) is HIGH, port nA is connected to port nB2 and nB1 is connected to GND via an internal pull-down resistor (500  $\Omega$ ).

The CBT16292 is characterized for operation from  $-40$  °C to  $+85$  °C.

### 2. Features

- 6  $\Omega$  switch connection between two ports
- TTL compatible input levels
- Break-before-make feature
- Internal 500  $\Omega$  pull-down resistors to ground
- ESD protection:
  - ◆ HBM JESD22-A114E Class 2 exceeds 2000 V
  - ◆ MM JESD22-A115-A exceeds 200 V
  - ◆ CDM JESD22-C101C exceeds 1000 V
- Latch-up performance exceeds 500 mA per JESD 78

### 3. Ordering information

Table 1. Ordering information

Type number	Package			Version
	Temperature range	Name	Description	
CBT16292DGG	$-40$ °C to $85$ °C	TSSOP56	plastic thin shrink small outline package; 56 leads; body width 6.1 mm	SOT364-1

#### 4. Functional diagram

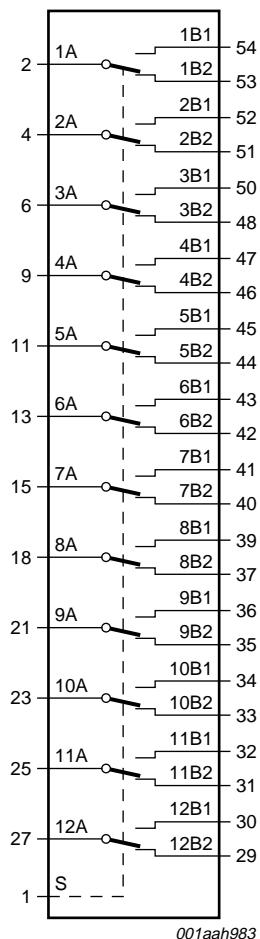


Fig 1. Logic symbol

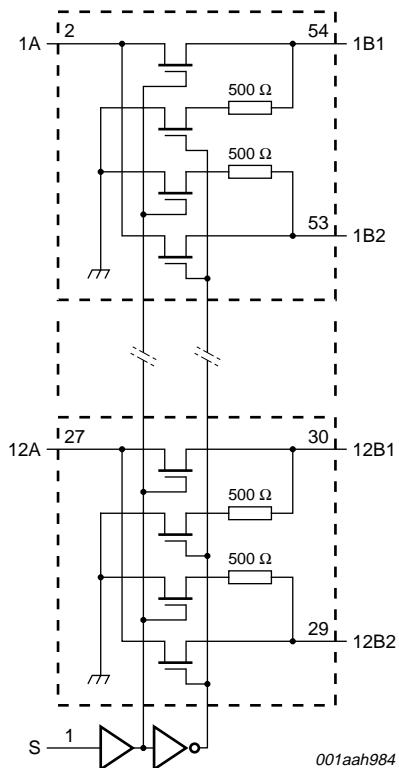


Fig 2. Logic diagram

## 5. Pinning information

### 5.1 Pinning

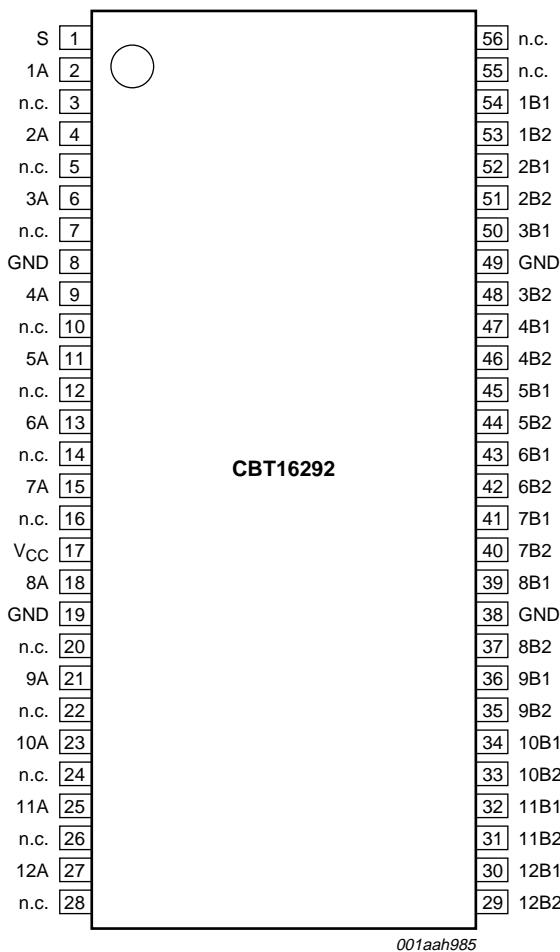


Fig 3. Pin configuration SOT364-1 (TSSOP56)

### 5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
S	1	select input
nA	2, 4, 6, 9, 11, 13, 15, 18, 21, 23, 25, 27	common input or output (1A to 12A)
n.c.	3, 5, 7, 10, 12, 14, 16, 20, 22, 24, 26, 28, 55, 56	not connected
GND	8, 19, 38, 49	ground (0 V)
V <sub>CC</sub>	17	supply voltage
nB1	54, 52, 50, 47, 45, 43, 41, 39, 36, 34, 32, 30	independent input or output (1B1 to 12B1)
nB2	53, 51, 48, 46, 44, 42, 40, 37, 35, 33, 31, 29	independent input or output (1B2 to 12B2)

## 6. Functional description

Table 3. Function selection<sup>[1]</sup>

S input	Channel on
L	nA to nB1 or nB1 to nA (nB2 connected to GND via internal resistor (500 Ω))
H	nA to nB2 or nB2 to nA (nB1 connected to GND via internal resistor (500 Ω))

[1] H = HIGH voltage level; L = LOW voltage level.

## 7. Limiting values

Table 4. Limiting values<sup>[1][2]</sup>

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC</sub>	supply voltage		-0.5	+7.0	V
V <sub>I</sub>	input voltage		<sup>[3]</sup> -0.5	+7.0	V
I <sub>IK</sub>	input clamping current	V <sub>I</sub> < 0 V	-50	-	mA
I <sub>SW</sub>	switch current	continuous current through channel	-128	+128	mA
T <sub>STG</sub>	storage temperature		-65	+150	°C
P <sub>TOT</sub>	total power dissipation	T <sub>AMB</sub> = -40 °C to +125 °C	<sup>[4]</sup> -	600	mW

- [1] Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- [2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150 °C.
- [3] The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.
- [4] P<sub>TOT</sub> derates linearly with 8 mW/K above 55 °C.

## 8. Recommended operating conditions

Table 5. Operating conditions

All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation.

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC</sub>	supply voltage		4.0	5.5	V
V <sub>IH</sub>	HIGH-level input voltage		2.0	-	V
V <sub>IL</sub>	LOW-level input voltage		-	0.8	V
T <sub>AMB</sub>	ambient temperature	operating in free-air	-40	+85	°C

## 9. Static characteristics

**Table 6. Static characteristics**

$T_{amb} = -40^{\circ}C$  to  $+85^{\circ}C$ .

Symbol	Parameter	Conditions	Min	Typ <sup>[1]</sup>	Max	Unit
$V_{IK}$	input clamping voltage	$V_{CC} = 4.5$ V; $I_I = -18$ mA	-	-	-1.2	V
$I_I$	input leakage current	$V_{CC} = 5.5$ V; $V_I = V_{CC}$ or GND	-	-	$\pm 5$	$\mu A$
$I_{CC}$	supply current	$V_{CC} = 5.5$ V; $I_O = 0$ mA; $V_I = V_{CC}$ or GND	-	-	3	$\mu A$
$\Delta I_{CC}$	additional supply current	per input; $V_{CC} = 5.5$ V; one input at 3.4 V, other inputs at $V_{CC}$ or GND	[2]	-	-	2.5 mA
$C_I$	input capacitance	select input S; $V_{CC} = 5.0$ V; $V_I = 3$ V or 0 V	-	4	-	pF
$C_{IO(off)}$	off-state input/output capacitance	$V_O = 3$ V or 0 V; $V_{CC} = 0$ V	-	6	-	pF
$R_{ON}$	ON resistance	$V_{CC} = 4.5$ V	[3]			
		$V_I = 0$ V; $I_I = 64$ mA	-	8	12.5	$\Omega$
		$V_I = 0$ V; $I_I = 30$ mA	-	8	11	$\Omega$
		$V_I = 2.4$ V; $I_I = 15$ mA	-	13	16	$\Omega$

[1] All typical values are measured at  $T_{amb} = 25^{\circ}C$ .

[2] This is the increase in supply current for each input that is at the specified TTL voltage level rather than  $V_{CC}$  or GND.

[3] Measured by the voltage drop between the A and the B terminals at the indicated current through the switch. ON resistance is determined by the lowest voltage of the two (A or B) terminals.

## 10. Dynamic characteristics

**Table 7. Dynamic characteristics**

$T_{amb} = -40^{\circ}C$  to  $+85^{\circ}C$ ;  $V_{CC} = 5.0$  V  $\pm 0.5$  V; for test circuit see [Figure 6](#).

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$t_{pd}$	propagation delay	nA, nBn to nBn, nA; see <a href="#">Figure 4</a>	[1][2]	-	-	0.4 ns
$t_{en}$	enable time	S to nA, nBn; see <a href="#">Figure 5</a>	[2]	1.5	-	6.0 ns
$t_{dis}$	disable time	S to nA, nBn; see <a href="#">Figure 5</a>	[2]	2.2	-	5.5 ns
$t_{b-m}$	break-before-make time	nA, nBn to nBn, nA	[3]	0	-	2.0 ns

[1] This parameter is warranted but not production tested. The propagation delay is based on the RC time constant of the typical ON resistance of the switch and a load capacitance, when driven by an ideal voltage source (zero output impedance).

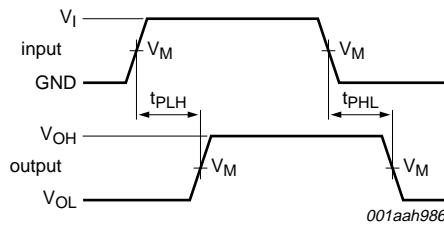
[2]  $t_{pd}$  is the same as  $t_{PLH}$  and  $t_{PHL}$ .

$t_{en}$  is the same as  $t_{PZL}$  and  $t_{PZH}$ .

$t_{dis}$  is the same as  $t_{PLZ}$  and  $t_{PHZ}$ .

[3] Time interval between break and make measured at the same operating point ( $V_{CC}$  and temperature).

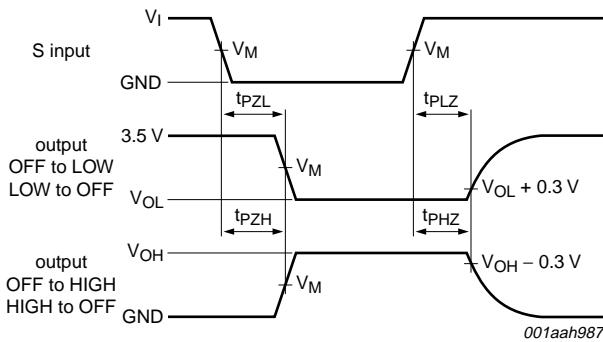
## 11. Waveforms



Measurement points are given in [Table 8](#).

$V_{OL}$  and  $V_{OH}$  are typical output voltage levels that occur with the output load.

**Fig 4. Input (nA or nBn) to output (nBn or nA) propagation delays**



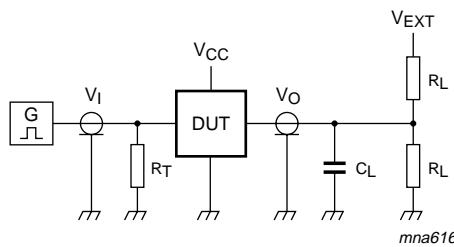
Measurement points are given in [Table 8](#).

$V_{OL}$  and  $V_{OH}$  are typical output voltage levels that occur with the output load.

**Fig 5. Enable and disable times**

**Table 8. Measurement points**

Supply voltage	Input	Output	
$V_{CC}$	$V_M$	$V_I$	$V_M$
4.5 V to 5.5 V	1.5 V	GND to 3.0 V	1.5 V



Test data is given in [Table 9](#).

Definitions for test circuit:

$R_L$  = Load resistance.

$C_L$  = Load capacitance including jig and probe capacitance.

$R_T$  = Termination resistance should be equal to the output impedance  $Z_0$  of the pulse generator.

$V_{EXT}$  = External voltage for measuring switching times.

**Fig 6. Test circuit**

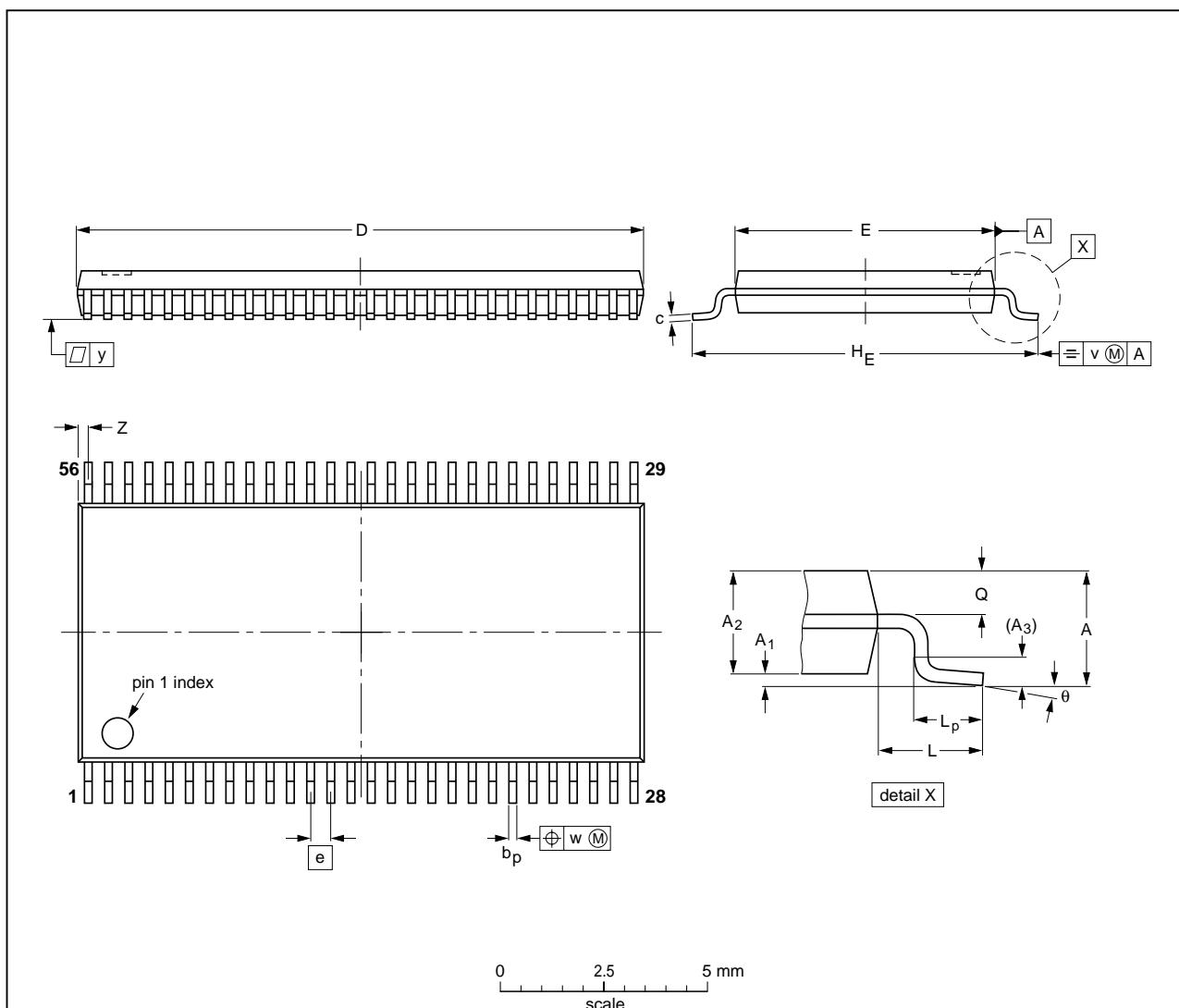
**Table 9. Test data**

Supply voltage	Input		Load		$V_{EXT}$		
$V_{CC}$	$V_I$	$t_r = t_f$	$C_L$	$R_L$	$t_{PLH}, t_{PHL}$	$t_{PZH}, t_{PHZ}$	$t_{PZL}, t_{PLZ}$
4.5 V to 5.5 V	GND to 3.0 V	$\leq 2.5$ ns	50 pF	500 $\Omega$	open	open	7.0 V

## 12. Package outline

TSSOP56: plastic thin shrink small outline package; 56 leads; body width 6.1 mm

SOT364-1



DIMENSIONS (mm are the original dimensions).

UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	b <sub>p</sub>	c	D <sup>(1)</sup>	E <sup>(2)</sup>	e	H <sub>E</sub>	L	L <sub>p</sub>	Q	v	w	y	z	θ
mm	1.2 0.05	0.15 0.85	1.05 0.25	0.25 0.17	0.28 0.17	0.2 0.1	14.1 13.9	6.2 6.0	0.5 0.5	8.3 7.9	1 1	0.8 0.4	0.50 0.35	0.25 0.25	0.08 0.08	0.1 0.1	0.5 0.1	8° 0°

Notes

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT364-1		MO-153				-99-12-27 03-02-19

Fig 7. Package outline SOT364-1 (TSSOP56)

## 13. Abbreviations

**Table 10. Abbreviations**

Acronym	Description
CDM	Charged Device Model
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
MM	Machine Model
TTL	Transistor-Transistor Logic

## 14. Revision history

**Table 11. Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes
CBT16292_2	20080418	Product data sheet	-	CBT16292_1
Modifications:	<ul style="list-style-type: none"><li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li><li>Legal texts have been adapted to the new company name where appropriate.</li><li>Changed <math>t_{en}</math> from 5.8 ns to 6.0 ns in <a href="#">Table 7 "Dynamic characteristics"</a>.</li></ul>			
CBT16292_1	19990913	Product specification	-	-

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Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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[2] The term 'short data sheet' is explained in section "Definitions".

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## 17. Contents

1	General description .....	1
2	Features .....	1
3	Ordering information .....	1
4	Functional diagram .....	2
5	Pinning information .....	3
5.1	Pinning .....	3
5.2	Pin description .....	3
6	Functional description .....	4
7	Limiting values .....	4
8	Recommended operating conditions .....	4
9	Static characteristics .....	5
10	Dynamic characteristics .....	5
11	Waveforms .....	6
12	Package outline .....	8
13	Abbreviations .....	9
14	Revision history .....	9
15	Legal information .....	10
15.1	Data sheet status .....	10
15.2	Definitions .....	10
15.3	Disclaimers .....	10
15.4	Trademarks .....	10
16	Contact information .....	10
17	Contents .....	11

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